



# M3000

## OLED Parameter Test System

Test Systems On Demands  
[www.mcscience.com](http://www.mcscience.com)

### All-in-one OLED Cell Characterization, Compact, Omnibus, and Easy to Use.

The M3000 OLED Parameter Test System consists of basically two major test components: M131 OLED Parameter Tester for electrical measurement and Qbism® HEXA colorimeter or LUMO spectroradiometer series for optical measurement. Without bulky environmental facility, this compact test system carries out multiple tests in user-programmed automatic sequence. Test items for OLED cell covers I-V-L characteristics, C-V characteristics, impedance measurement, transient analysis, and optionally simultaneous view angle measurement as well as temperature dependence using ThermoStation®, and various device parameters can be extracted from a series of measurements and recorded as metadata.



**I-V-L Measurement**

**Luminescence / Color / Spectrum Measurement**

**Luminous / Power / Quantum Efficiency**

**Capacitance Measurement**

**Frequency Response Analysis**

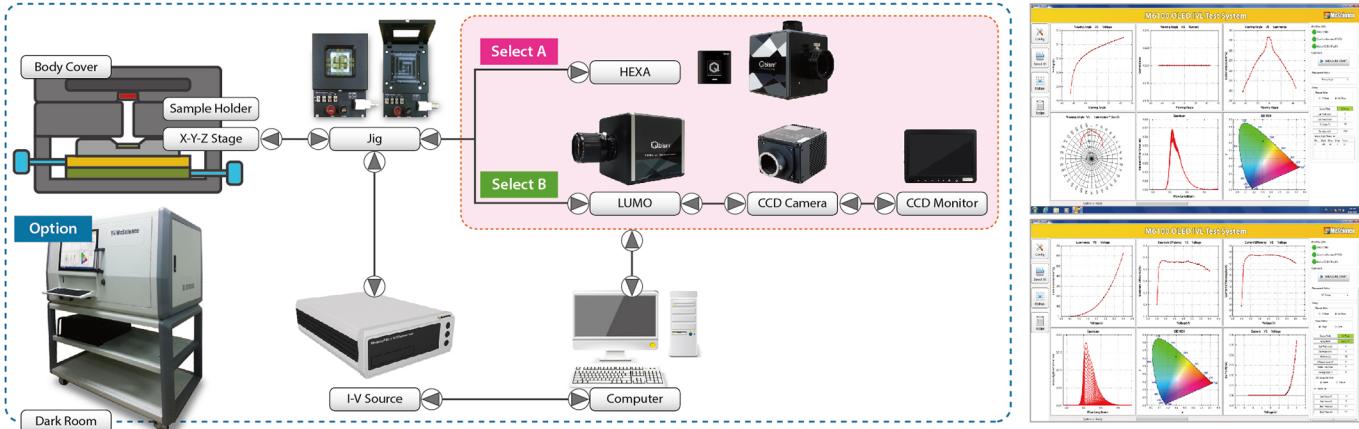
**View Angle Measurement**

**Temperature Control**



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## System Configuration



## System Components



## System Specification

Product Model		M3000 OLED Parameter Test System		
System Configuration		I-V Source Measure Unit, JIG and Frame(Drawer Type), I-V-L Test Software, Temperature/View Angle		
Source	Mode	DC, Sweep, Pulse, Sine, Arbitrary	Photodiode	150mA, 500uA
	Voltage Range	±30V, ±3±, ±300mV	Interface(with HEXA)	Digital Communication(I2C)
	Measurement Range	30V, 3V, 300mV, 30mV(DC Canceling)	Temperature Measurement	Thermocouple 1CH
	Current Range	500mA, 50mA, 5mA, 500uA, 50uA, 5uA	Output/Measurement Port	I+, I-, V+, V-, Guard, Gnd
Luminance	Range	10~100,000 cd/m <sup>2</sup> (HEXA), 1~100,000 cd/m <sup>2</sup> (LUMO)		
	Accuracy	±4%(@10.0~100,000cd/m <sup>2</sup> ), ±3%(@1~100,000cd/m <sup>2</sup> )		
Chromaticity Accuracy		±0.005 (10~100,000 cd/m <sup>2</sup> ) / ±0.003 (1~100,000 cd/m <sup>2</sup> )		
Measurement Speed		2sec(HEXA), 2 ~ 200sec(LUMO)		
Measurement		Time, Voltage, Current, xyLv, XYZ, TΔuvLv, u'v'Lv, CCT, CRI		
PC Interface		USB2.0 / 3.0		